

**Notice of References Cited**

Application/Control No.

10/594,053

Applicant(s)/Patent Under  
Reexamination  
NISHIO, AKIHIKO

Examiner

OMAR GHOWRWAL

Art Unit

2416

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0136271 A1	09-2002	Hiramatsu et al.	375/141
*	B	US-6,735,178 B1	05-2004	Srivastava et al.	370/252
*	C	US-2003/0073409 A1	04-2003	Nobukiyo et al.	455/67.1
*	D	US-2005/0037766 A1	02-2005	Hans et al.	455/450
*	E	US-2002/0126645 A1	09-2002	Ryu, Seung Moon	370/342
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.